Power MOSFET

–60 V, 16 m Ω , –61 A, Single P–Channel

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- High Current Capability
- Avalanche Energy Specified
- AEC-Q101 Qualified
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

WAXIMUM RATINGS (1 _J = 25°C unless otherwise noted)						
Parameter			Symbol	Value	Unit	
Drain-to-Source Voltage			V _{DSS}	-60	V	
Gate-to-Source Voltage			V _{GS}	±20	V	
Continuous Drain Cur-		$T_{C} = 25^{\circ}C$	I _D	-61	А	
rent R _{θJC} (Note 1)	Steady	$T_{C} = 100^{\circ}C$		-43		
Power Dissipation $R_{\theta JC}$	State	$T_{\rm C} = 25^{\circ}{\rm C}$	PD	118	W	
(Note 1)		$T_{C} = 100^{\circ}C$		59		
Continuous Drain Cur-		$T_A = 25^{\circ}C$	I _D	-11	А	
rent $R_{\theta JA}$ (Notes 1 & 2)	Steady State	$T_A = 100^{\circ}C$		-8		
Power Dissipation $R_{\theta JA}$		T _A = 25°C	PD	4.1	W	
(Notes 1 & 2)		T _A = 100°C		2.1		
Pulsed Drain Current	$T_{A} = 25^{\circ}$	T _A = 25°C, t _p = 10 μs		-419	А	
Current Limited by Package (Note 3)	T _A	= 25°C	I _{Dmaxpkg}	60	А	
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to 175	°C	
Source Current (Body Diode)			۱ _S	-118	А	
Single Pulse Drain-to-Source Avalanche Energy (T _J = 25°C, V _{DD} = 50 V, V _{GS} = 10 V, $I_{L(pk)}$ = 40 A, L = 0.3 mH, R _G = 25 Ω)			E _{AS}	240	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Drain)	$R_{\theta JC}$	1.3	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	37	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

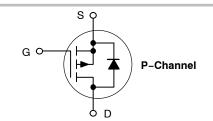
3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



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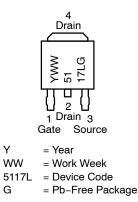
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V _{(BR)DSS}	V _{(BR)DSS} R _{DS(on)}		
–60 V	16 mΩ @ –10 V	-61 A	
	22 mΩ @ –4.5 V	-01 A	





MARKING DIAGRAMS & PIN ASSIGNMENT



ORDERING INFORMATION

Device	Package	Shipping [†]
NVD5117PLT4G	DPAK (Pb-Free)	2500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

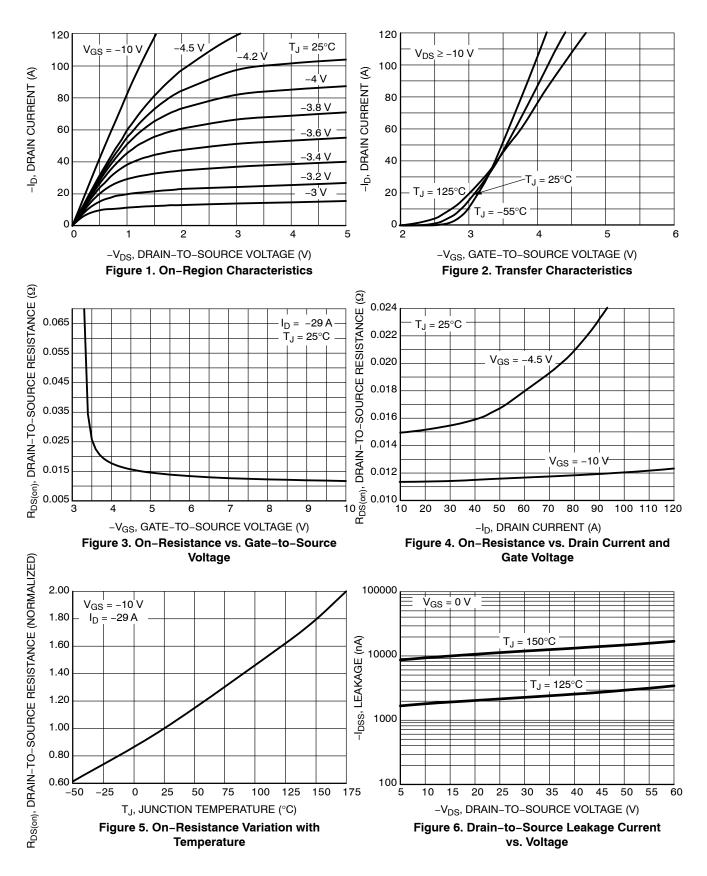
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ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

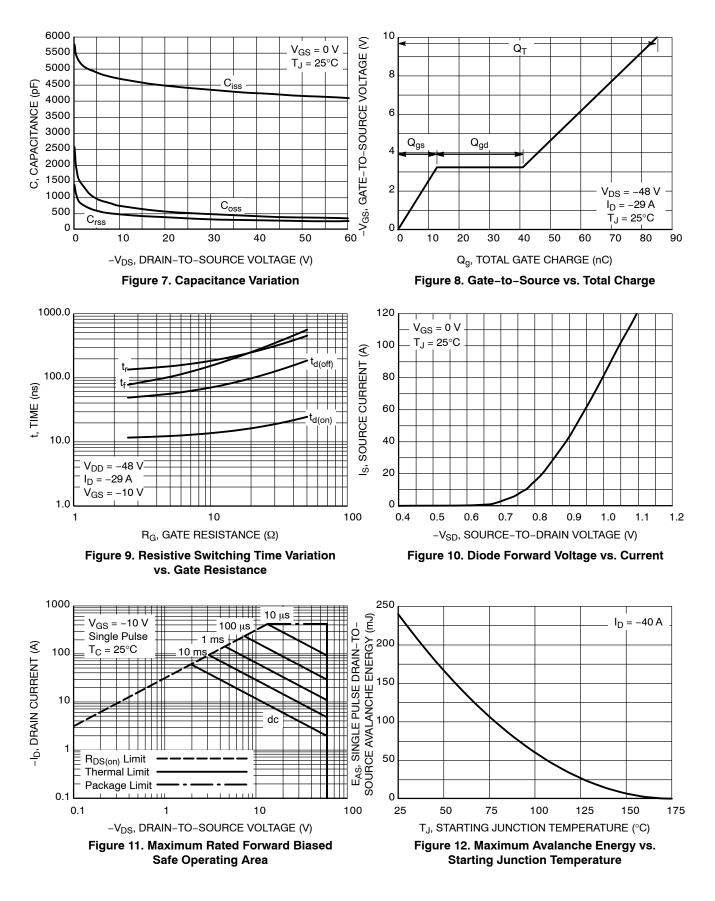
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS					· ·		-
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = –250 μ A		-60			V
Zero Gate Voltage Drain Current	I_{DSS} $V_{GS} = 0 V$, $T_J =$		$T_J = 25^{\circ}C$			-1.0	μΑ
		$V_{\rm DS} = -60 \text{ V}$ $T_{\rm J} = 125^{\circ}\text{C}$				-100	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	s = ±20 V			±100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D$	= –250 μA	-1.5		-2.5	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = -10 V, I	_D = -29 A		12	16	mΩ
		V _{GS} = -4.5 V,	_D = -29 A		16	22	
Froward Transconductance	9fs	V _{DS} = -15 V, I	_D = -15 A		30		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	V _{GS} = 0 V, f =	1.0 MHz,		4800		pF
Output Capacitance	C _{oss}	$V_{DS} = -2$	25 V		480		
Reverse Transfer Capacitance	C _{rss}				320		
Total Gate Charge	Q _{G(TOT)}	V _{DS} = -48 V, I _D = -29 A	V_{GS} = -4.5 V		49		nC
			$V_{GS} = -10 \text{ V}$		85		
Threshold Gate Charge	Q _{G(TH)}	V_{GS} = -4.5 V, V_{DS} = -48 V, I _D = -29 A			3		
Gate-to-Source Charge	Q _{GS}				13		1
Gate-to-Drain Charge	Q _{GD}				28		
Plateau Voltage	V _{GP}				3.2		V
SWITCHING CHARACTERISTICS (No	tes 4)						
Turn-On Delay Time	t _{d(on)}				22		ns
Rise Time	t _r	V _{GS} = -4.5 V, V _I	_{DS} = -48 V.		195		1
Turn–Off Delay Time	t _{d(off)}	$V_{GS} = -4.3 \text{ v}, V_{DS} = -48 \text{ v},$ $I_D = -29 \text{ A}, \text{ R}_G = 2.5 \Omega$			50		1
Fall Time	t _f				132		1
DRAIN-SOURCE DIODE CHARACTE	RISTICS				-		-
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$		-0.86	-1.0	V
		I _S = -29 A T _J = 125°C			-0.74		1
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dl _s /dt = 100 A/µs, I _s = -29 A			36		ns
Charge Time	ta				19		1
Discharge Time	t _b				17		1
Reverse Recovery Charge	Q _{RR}				44		nC

4. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.

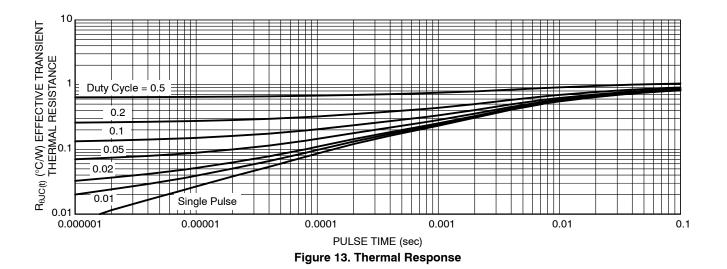
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

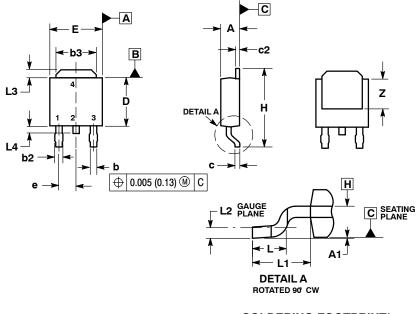


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PACKAGE DIMENSIONS

DPAK (SINGLE GAUGE) CASE 369C-01

ISSUE D

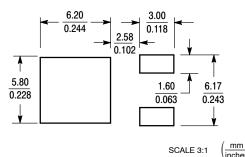


NOTES

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M. 1994
- CONTROLLING DIMENSION: INCHES.
- CONTROLLING DIMENSION: INCHES.
 THERMAL PAD CONTOUR OPTIONAL WITHIN DI-MENSIONS b3, L3 and Z.
 DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
 DIMENSIONS ON GATE BURRS SHALL NOT EXCEED 0.006 INCHES PER SIDE.
- DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY. 6. DATUMS A AND B ARE DETERMINED AT DATUM
- PLANE H.

	INC	HES	MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.086	0.094	2.18	2.38	
A1	0.000	0.005	0.00	0.13	
b	0.025	0.035	0.63	0.89	
b2	0.030	0.045	0.76	1.14	
b3	0.180	0.215	4.57	5.46	
С	0.018	0.024	0.46	0.61	
c2	0.018	0.024	0.46	0.61	
D	0.235	0.245	5.97	6.22	
Е	0.250	0.265	6.35	6.73	
е	0.090	BSC	2.29	BSC	
Н	0.370	0.410	9.40	10.41	
L	0.055	0.070	1.40	1.78	
L1	0.108	REF	2.74	.74 REF	
L2	0.020	BSC	0.51	BSC	
L3	0.035	0.050	0.89	1.27	
L4		0.040		1.01	
Z	0.155		3.93		

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and

Mounting Techniques Reference Manual, SOLDERRM/D.

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